Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/667,004	CHAN ET AL.	
Examiner	Art Unit	
Frank W. Lu	1634	

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	SEAR	CHED	
Class	Subclass	Date	Examiner
435	6 1.1 91.1	5/12/206	N
	183		
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536	23-1		
	24.3		
730	300		
	350		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
57N	DATE	EXMR
STN East (see attached file)	t/12/206	N